

Figure 1. Pin Assignment

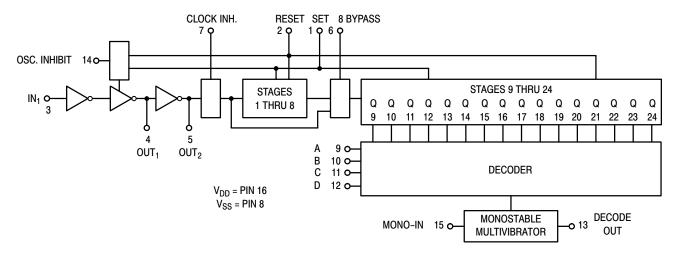


Figure 2. Block Diagram

FUNCTION TABLE

| In ₁ | Set | Reset | Clock Inh | OSC Inh | Out 1 | Out 2 | Decode Out |
|-----------------|-----|-------|--------------|------------|-------|-------|--------------------------|
| | 0 | 0 | 0 | 0 | | ~ | No Change |
| ~_ | 0 | 0 | 0 | 0 | ~ | \ | Advance to next state |
| Х | 1 | 0 | 0 | 0 | 0 | 1 | 1 |
| Х | 0 | 1 | 0 | 0 | 0 | 1 | 0 |
| Х | 0 | 0 | 1 | 0 | - | - | No Change |
| Х | 0 | 0 | 0 | 1 | 0 | 1 | No Change |
| 0 | 0 | 0 | 0 | Х | 0 | 1 | No Change |
| 1 | 0 | 0 | 0 | | ~ | | Advance to next state |

X = Don't Care

ELECTRICAL CHARACTERISTICS (Voltages Referenced to V_{SS})

| | | | | - 5 | 5°C | | 25°C | | 125 | 5°C | |
|---|----------------------|-----------------|------------------------|------------------------------------|----------------------|-----------------------------------|---|----------------------|------------------------------------|----------------------|------|
| Characterist | ic | Symbol | V _{DD} Vdc | Min | Max | Min | Typ (Note 2) | Max | Min | Max | Unit |
| Output Voltage V _{in} = V _{DD} or 0 | "0" Level | V _{OL} | 5.0 10 15 | | 0.05 0.05 0.05 | - - - | 0 0 0 | 0.05 0.05 0.05 | - - - | 0.05 0.05 0.05 | Vdc |
| V _{in} = 0 or V _{DD} | "1" Level | V _{OH} | 5.0 10 15 | 4.95 9.95 14.95 | - - - | 4.95 9.95 14.95 | 5.0 10 15 | - - - | 4.95 9.95 14.95 | _ _ _ | Vdc |
| Input Voltage (V _O = 4.5 or 0.5 Vdc) (V _O = 9.0 or 1.0 Vdc) (V _O = 13.5 or 1.5 Vdc) | "0" Level | V _{IL} | 5.0 10 15 | - - - | 1.5 3.0 4.0 | - - - | 2.25 4.50 6.75 | 1.5 3.0 4.0 | - - - | 1.5 3.0 4.0 | Vdc |
| (V _O = 0.5 or 4.5 Vdc) (V _O = 1.0 or 9.0 Vdc) (V _O = 1.5 or 13.5 Vdc) | "1" Level | V _{IH} | 5.0 10 15 | 3.5 7.0 11 | - - - | 3.5 7.0 11 | 2.75 5.50 8.25 | - - - | 3.5 7.0 11 | - - - | Vdc |
| Output Drive Current $(V_{OH} = 2.5 \text{ Vdc})$ $(V_{OH} = 4.6 \text{ Vdc})$ $(V_{OH} = 9.5 \text{ Vdc})$ $(V_{OH} = 13.5 \text{ Vdc})$ | Source Pins 4 & 5 | I _{OH} | 5.0 5.0 10 15 | - 1.2 - 0.25 - 0.62 - 1.8 | - - - | - 1.0 - 0.25 - 0.5 - 1.5 | - 1.7 - 0.36 - 0.9 - 3.5 | - - - | - 0.7 - 0.14 - 0.35 - 1.1 | - - - - | mAdc |
| | Source Pin 13 | | 5.0 5.0 10 15 | - 3.0 - 0.64 - 1.6 - 4.2 | - - - | - 2.4 - 0.51 - 1.3 - 3.4 | - 4.2 - 0.88 - 2.25 - 8.8 | - - - | - 1.7 - 0.36 - 0.9 - 2.4 | - - - - | mAdc |
| $(V_{OL} = 0.4 \text{ Vdc})$ $(V_{OL} = 0.5 \text{ Vdc})$ $(V_{OL} = 1.5 \text{ Vdc})$ | Sink | I _{OL} | 5.0 10 15 | 0.64 1.6 4.2 | - - - | 0.51 1.3 3.4 | 0.88 2.25 8.8 | - - - | 0.36 0.9 2.4 | - - - | mAdc |
| Input Current | | I _{in} | 15 | - | ±0.1 | - | ±0.00001 | ±0.1 | _ | ±1.0 | μAdc |
| Input Capacitance (V _{in} = 0) | | C _{in} | - | _ | - | - | 5.0 | 7.5 | _ | - | pF |
| Quiescent Current (Per | Package) | I _{DD} | 5.0 10 15 | - - - | 5.0 10 20 | - - - | 0.010 0.020 0.030 | 5.0 10 20 | - - - | 150 300 600 | μAdc |
| Total Supply Current (N (Dynamic plus Quiesce Per Package) (C _L = 50 pF on all outp buffers switching) | ent, | I _T | 5.0 10 15 | | | $I_{T} = (2$ | .50 μΑ/kHz) .30 μΑ/kHz) .55 μΑ/kHz) | f + I _{DD} | | | μAdc |

Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.
 The formulas given are for the typical characteristics only at 25°C.
 To calculate total supply current at loads other than 50 pF:

$$I_T(C_L) = I_T(50 \text{ pF}) + (C_L - 50) \text{ Vfk}$$

where: I_T is in μA (per package), C_L in pF, $V = (V_{DD} - V_{SS})$ in volts, f in kHz is input frequency, and k = 0.003.

SWITCHING CHARACTERISTICS (Note 5) ($C_L = 50 \text{ pF}, T_A = 25^{\circ}\text{C}$)

| Characteristic | Symbol | V_{DD} | Min | Typ (Note 6) | Max | Unit |
|--|--|-----------------|--------------------|--------------------|----------------------|------|
| Output Rise and Fall Time (Pin 13) t_{TLH} , t_{THL} = (1.5 ns/pF) C_L + 25 ns t_{TLH} , t_{THL} = (0.75 ns/pF) C_L + 12.5 ns t_{TLH} , t_{THL} = (0.55 ns/pF) C_L + 9.5 ns | t _{TLH} , t _{THL} | 5.0 10 15 | - - - | 100 50 40 | 200 100 80 | ns |
| Propagation Delay Time Clock to Q1, 8–Bypass (Pin 6) High t_{PLH} , t_{PHL} = (1.7 ns/pF) C_L + 1715 ns t_{PLH} , t_{PHL} = (0.66 ns/pF) C_L + 617 ns t_{PLH} , t_{PHL} = (0.5 ns/pF) C_L + 425 ns | t _{PLH} , t _{PHL} | 5.0 10 15 | - - - | 1800 650 450 | 3600 1300 1000 | ns |
| Clock to Q1, 8–Bypass (Pin 6) Low t_{PLH} , t_{PHL} = (1.7 ns/pF) C_L + 3715 ns t_{PLH} , t_{PHL} = (0.66 ns/pF) C_L + 1467 ns t_{PLH} , t_{PHL} = (0.5 ns/pF) C_L + 1075 ns | t _{PLH} , t _{PHL} | 5.0 10 15 | - - - | 3.8 1.5 1.1 | 7.6 3.0 2.3 | μs |
| Clock to Q16 t_{PHL} , t_{PLH} = (1.7 ns/pF) C_L + 6915 ns t_{PHL} , t_{PLH} = (0.66 ns/pF) C_L + 2967 ns t_{PHL} , t_{PLH} = (0.5 ns/pF) C_L + 2175 ns | t _{PLH} , t _{PHL} | 5.0 10 15 | - - - | 7.0 3.0 2.2 | 14 6.0 4.5 | μs |
| Reset to Q_n $t_{PHL} = (1.7 \text{ ns/pF}) C_L + 1415 \text{ ns}$ $t_{PHL} = (0.66 \text{ ns/pF}) C_L + 567 \text{ ns}$ $t_{PHL} = (0.5 \text{ ns/pF}) C_L + 425 \text{ ns}$ | t _{PHL} | 5.0 10 15 | - - - | 1500 600 450 | 3000 1200 900 | ns |
| Clock Pulse Width | t _{WH} | 5.0 10 15 | 600 200 170 | 300 100 85 | - - - | ns |
| Clock Pulse Frequency (50% Duty Cycle) | f _{cl} | 5.0 10 15 | - - - | 1.2 3.0 5.0 | 0.4 1.5 2.0 | MHz |
| Clock Rise and Fall Time | t _{TLH} , t _{THL} | 5.0 10 15 | | No Limit | | - |
| Reset Pulse Width | t _{WH} | 5.0 10 15 | 1000 400 300 | 500 200 150 | - - - | ns |

^{5.} The formulas given are for the typical characteristics only at 25°C.
6. Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.

PIN DESCRIPTIONS

INPUTS

SET (Pin 1) –A high on Set asynchronously forces Decode Out to a high level. This is accomplished by setting an output conditioning latch to a high level while at the same time resetting the 24 flip–flop stages. After Set goes low (inactive), the occurrence of the first negative clock transition on IN_1 causes Decode Out to go low. The counter's flip–flop stages begin counting on the second negative clock transition of IN_1 . When Set is high, the on–chip RC oscillator is disabled. This allows for very low–power standby operation.

RESET (Pin 2) – A high on Reset asynchronously forces Decode Out to a low level; all 24 flip—flop stages are also reset to a low level. Like the Set input, Reset disables the on–chip RC oscillator for standby operation.

 IN_1 (Pin 3) – The device's internal counters advance on the negative–going edge of this input. IN_1 may be used as an external clock input or used in conjunction with OUT_1 and OUT_2 to form an RC oscillator. When an external clock is used, both OUT_1 and OUT_2 may be left unconnected or used to drive 1 LSTTL or several CMOS loads.

8–BYPASS (**Pin 6**) – A high on this input causes the first 8 flip–flop stages to be bypassed. This device essentially becomes a 16–stage counter with all 16 stages selectable. Selection is accomplished by the A, B, C, and D inputs. (See the truth tables.)

CLOCK INHIBIT (**Pin 7**) – A high on this input disconnects the first counter stage from the clocking source. This holds the present count and inhibits further counting. However, the clocking source may continue to run. Therefore, when Clock Inhibit is brought low, no oscillator startup time is required. When Clock Inhibit is low, the counter will start counting on the occurrence of the first negative edge of the clocking source at IN_1 .

OSC INHIBIT (Pin 14) – A high level on this pin stops the RC oscillator which allows for very low–power standby operation. May also be used, in conjunction with an external clock, with essentially the same results as the Clock Inhibit input.

MONO–IN (**Pin 15**) – Used as the timing pin for the on–chip monostable multivibrator. If the Mono–In input is connected to V_{SS} , the monostable circuit is disabled, and Decode Out is directly connected to the selected Q output. The monostable circuit is enabled if a resistor is connected between Mono–In and V_{DD} . This resistor and the device's internal capacitance will determine the minimum output pulse widths. With the addition of an external capacitor to V_{SS} , the pulse width range may be extended. For reliable operation the resistor value should be limited to the range of 5 k Ω to 100 k Ω and the capacitor value should be limited to a maximum of 1000 pf. (See figures 5, 6, 7, and 12).

A, B, C, D (**Pins 9, 10, 11, 12**) – These inputs select the flip–flop stage to be connected to Decode Out. (See the truth tables.)

OUTPUTS

OUT₁, OUT₂ (Pin 4, 5) – Outputs used in conjunction with IN₁ to form an RC oscillator. These outputs are buffered and may be used for 2⁰ frequency division of an external clock.

DECODE OUT (Pin 13) – Output function depends on configuration. When the monostable circuit is disabled, this output is a 50% duty cycle square wave during free run.

TEST MODE

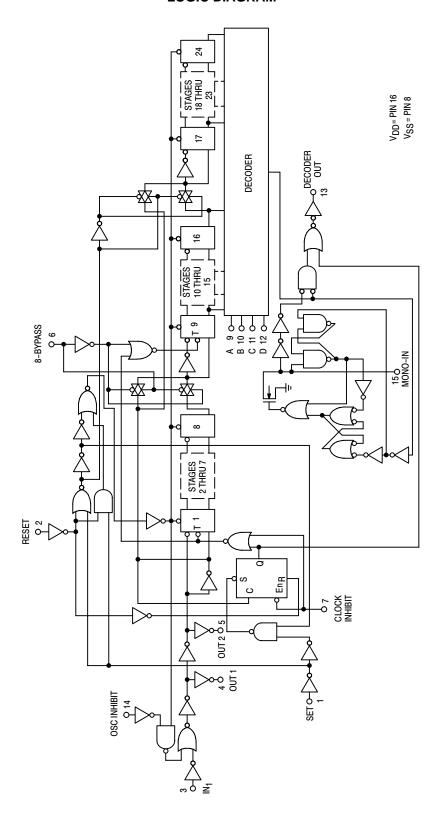
The test mode configuration divides the 24 flip-flop stages into three 8-stage sections to facilitate a fast test sequence. The test mode is enabled when 8-Bypass, Set and Reset are at a high level. (See Figure 10.)

TRUTH TABLES

| | In | Stage Selected | | | |
|----------|----|----------------|---|---|----------------|
| 8-Bypass | D | С | В | Α | for Decode Out |
| 0 | 0 | 0 | 0 | 0 | 9 |
| 0 | 0 | 0 | 0 | 1 | 10 |
| 0 | 0 | 0 | 1 | 0 | 11 |
| 0 | 0 | 0 | 1 | 1 | 12 |
| 0 | 0 | 1 | 0 | 0 | 13 |
| 0 | 0 | 1 | 0 | 1 | 14 |
| 0 | 0 | 1 | 1 | 0 | 15 |
| 0 | 0 | 1 | 1 | 1 | 16 |
| 0 | 1 | 0 | 0 | 0 | 17 |
| 0 | 1 | 0 | 0 | 1 | 18 |
| 0 | 1 | 0 | 1 | 0 | 19 |
| 0 | 1 | 0 | 1 | 1 | 20 |
| 0 | 1 | 1 | 0 | 0 | 21 |
| 0 | 1 | 1 | 0 | 1 | 22 |
| 0 | 1 | 1 | 1 | 0 | 23 |
| 0 | 1 | 1 | 1 | 1 | 24 |

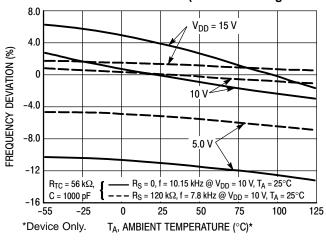
| | In | Stage Selected | | | |
|----------|----|----------------|---|---|----------------|
| 8-Bypass | D | С | В | Α | for Decode Out |
| 1 | 0 | 0 | 0 | 0 | 1 |
| 1 | 0 | 0 | 0 | 1 | 2 |
| 1 | 0 | 0 | 1 | 0 | 3 |
| 1 | 0 | 0 | 1 | 1 | 4 |
| 1 | 0 | 1 | 0 | 0 | 5 |
| 1 | 0 | 1 | 0 | 1 | 6 |
| 1 | 0 | 1 | 1 | 0 | 7 |
| 1 | 0 | 1 | 1 | 1 | 8 |
| 1 | 1 | 0 | 0 | 0 | 9 |
| 1 | 1 | 0 | 0 | 1 | 10 |
| 1 | 1 | 0 | 1 | 0 | 11 |
| 1 | 1 | 0 | 1 | 1 | 12 |
| 1 | 1 | 1 | 0 | 0 | 13 |
| 1 | 1 | 1 | 0 | 1 | 14 |
| 1 | 1 | 1 | 1 | 0 | 15 |
| 1 | 1 | 1 | 1 | 1 | 16 |

LOGIC DIAGRAM



TYPICAL RC OSCILLATOR CHARACTERISTICS

(For Circuit Diagram See Figure 13 In Application)



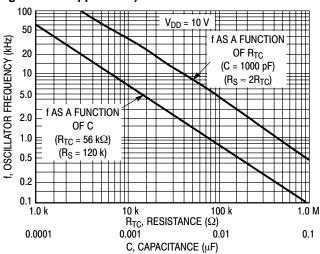
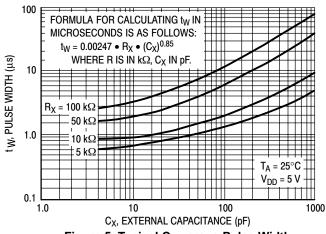


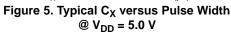
Figure 3. RC Oscillator Stability

Figure 4. RC Oscillator Frequency as a Function of R_{TC} and C

MONOSTABLE CHARACTERISTICS

(For Circuit Diagram See Figure 12 In Application)





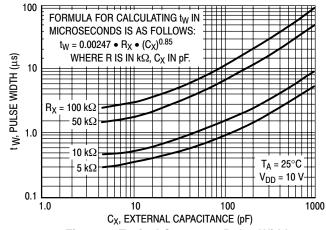


Figure 6. Typical C_X versus Pulse Width @ $V_{DD} = 10 \text{ V}$

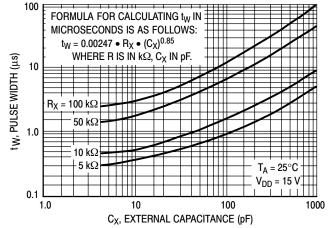


Figure 7. Typical C_X versus Pulse Width @ $V_{DD} = 15 \text{ V}$

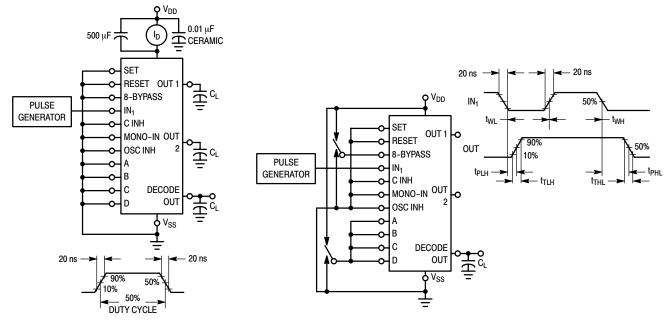
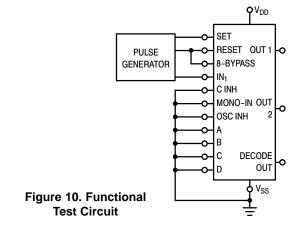


Figure 8. Power Dissipation Test Circuit and Waveform

Figure 9. Switching Time Test Circuit and Waveforms

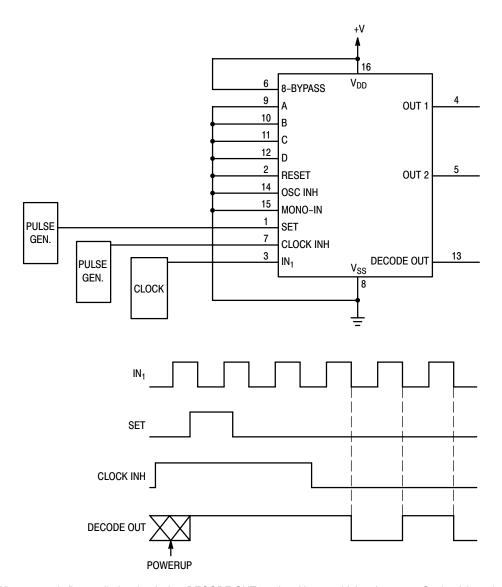
FUNCTIONAL TEST SEQUENCE

Test function (Figure 10) has been included for the reduction of test time required to exercise all 24 counter stages. This test function divides the counter into three 8-stage sections and 255 counts are loaded in each of the 8-stage sections in parallel. All flip-flops are now at a "1". The counter is now returned to the normal 24-stages in series configuration. One more pulse is entered into In₁ which will cause the counter to ripple from an all "1" state to an all "0" state.



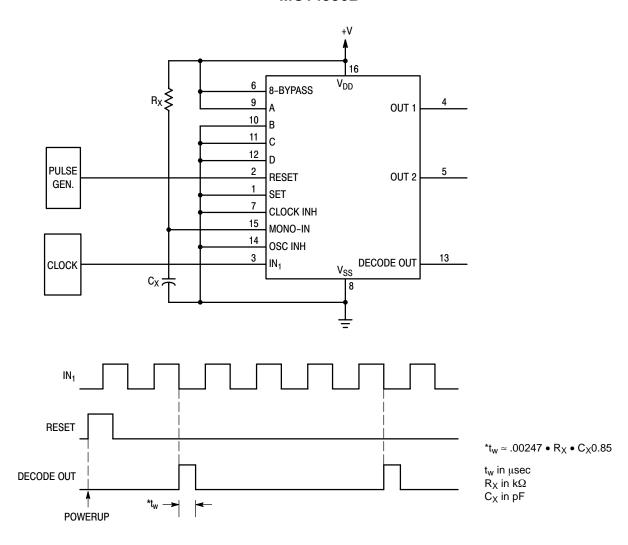
FUNCTIONAL TEST SEQUENCE

| | Inputs | | | Outputs | Comments | |
|------------------|--------|-------|----------|---------------------------|---|--|
| In ₁ | Set | Reset | 8-Bypass | Decade Out Q1 thru Q24 | All 24 stages are in Reset mode. | |
| 1 | 0 | 1 | 1 | 0 | | |
| 1 | 1 | 1 | 1 | 0 | Counter is in three 8 stage sections in parallel mode. | |
| 0 | 1 | 1 | 1 | 0 | First "1" to "0" transition of clock. | |
| 1 0 - - | 1 | 1 | 1 | | 255 "1" to "0" transitions are clocked in the counter. | |
| 0 | 1 | 1 | 1 | 1 | The 255 "1" to "0" transition. | |
| 0 | 0 | 0 | 0 | 1 | Counter converted back to 24 stages in series mode. Set and Reset must be connected together and simultaneously go from "1" to "0". | |
| 1 | 0 | 0 | 0 | 1 | In ₁ Switches to a "1". | |
| 0 | 0 | 0 | 0 | 0 | Counter Ripples from an all "1" state to an all "0" state. | |



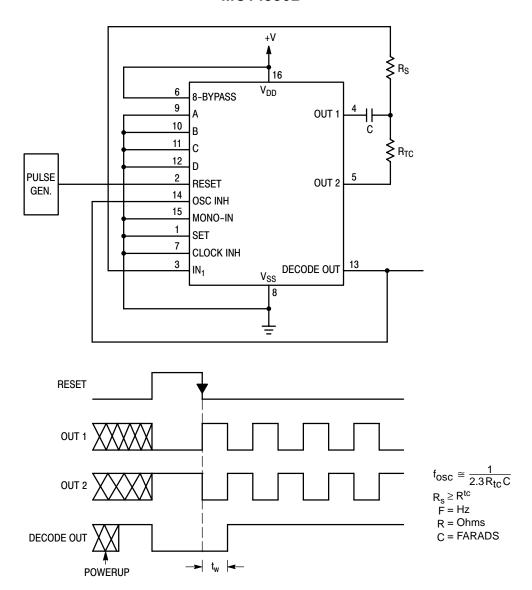
NOTE: When power is first applied to the device, DECODE OUT can be either at a high or low state. On the rising edge of a SET pulse the output goes high if initially at a low state. The output remains high if initially at a high state. Because CLOCK INH is held high, the clock source on the input pin has no effect on the output. Once CLOCK INH is taken low, the output goes low on the first negative clock transition. The output returns high depending on the 8–BYPASS, A, B, C, and D inputs, and the clock input period. A 2ⁿ frequency division (where n = the number of stages selected from the truth table) is obtainable at DECODE OUT. A 2ⁿ-divided output of IN₁ can be obtained at OUT₁ and OUT₂.

Figure 11. Time Interval Configuration Using an External Clock, Set, and Clock Inhibit Functions (Divide-by-2 Configured)



NOTE: When Power is first applied to the device with the RESET input going high, DECODE OUT initializes low. Bringing the RESET input low enables the chip's internal counters. After RESET goes low, the 2ⁿ/2 negative transition of the clock input causes DECODE OUT to go high. Since the MONO–IN input is being used, the output becomes monostable. The pulse width of the output is dependent on the external timing components. The second and all subsequent pulses occur at 2ⁿ x (the clock period) intervals where n = the number of stages selected from the truth table.

Figure 12. Time Interval Configuration Using an External Clock, Reset, and Output Monostable to Achieve a Pulse Output (Divide-by-4 Configured)



NOTE: This circuit is designed to use the on–chip oscillation function. The oscillator frequency is determined by the external R and C components. When power is first applied to the device, DECODE OUT initializes to a high state. Because this output is tied directly to the OSC INH input, the oscillator is disabled. This puts the device in a low–current standby condition. The rising edge of the RESET pulse will cause the output to go low. This in turn causes OSC INH to go low. However, while RESET is high, the oscillator is still disabled (i.e.: standby condition). After RESET goes low, the output remains low for 2ⁿ/2 of the oscillator's period. After the part times out, the output again goes high.

Figure 13. Time Interval Configuration Using On–Chip RC Oscillator and Reset Input to Initiate Time Interval (Divide–by–2 Configured)

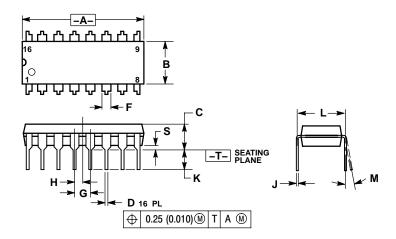
ORDERING INFORMATION

| Device | Package | Shipping [†] | |
|---------------|------------------------|-----------------------|--|
| MC14536BCP | PDIP-16 | | |
| MC14536BCPG | PDIP-16 (Pb-Free) | 25 Units / Rail | |
| MC14536BDW | SOIC-16 | | |
| MC14536BDWG | SOIC-16 (Pb-Free) | 47 Units / Rail | |
| MC14536BDWR2 | SOIC-16 | | |
| MC14536BDWR2G | SOIC-16 (Pb-Free) | 1000 / Tape & Reel | |
| MC14536BFEL | SOEIAJ-16 | | |
| MC14536BFELG | SOEIAJ-16 (Pb-Free) | 2000 / Tape & Reel | |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

PDIP-16 CASE 648-08 **ISSUE T**

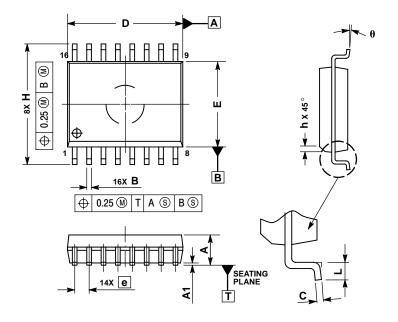


- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.
 DIMENSION L TO CENTER OF LEADS
 WHEN FORMED PARALLEL.
- DIMENSION B DOES NOT INCLUDE
- MOLD FLASH.

 5. ROUNDED CORNERS OPTIONAL.

| | INC | HES | MILLIN | IETERS | |
|-----|-------|-------|----------|--------|--|
| DIM | MIN | MAX | MIN | MAX | |
| Α | 0.740 | 0.770 | 18.80 | 19.55 | |
| В | 0.250 | 0.270 | 6.35 | 6.85 | |
| С | 0.145 | 0.175 | 3.69 | 4.44 | |
| D | 0.015 | 0.021 | 0.39 | 0.53 | |
| F | 0.040 | 0.70 | 1.02 | 1.77 | |
| G | 0.100 | BSC | 2.54 BSC | | |
| Н | 0.050 | BSC | 1.27 BSC | | |
| J | 0.008 | 0.015 | 0.21 | 0.38 | |
| K | 0.110 | 0.130 | 2.80 | 3.30 | |
| L | 0.295 | 0.305 | 7.50 | 7.74 | |
| M | 0° | 10 ° | 0° | 10 ° | |
| S | 0.020 | 0.040 | 0.51 | 1.01 | |

SOIC-16WB CASE 751G-03 **ISSUE C**

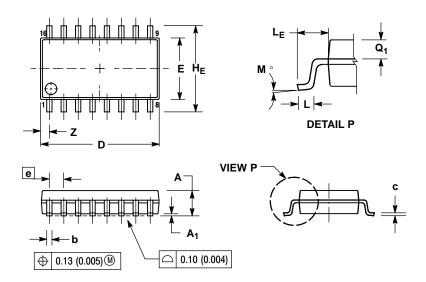


- NOTES:
 1. DIMENSIONS ARE IN MILLIMETERS.
 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
 3. DIMENSIONS D AND E DO NOT INLCUDE MOLD PROTRUSION.
 4. MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.
 5. DIMENSION B DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF THE B DIMENSION AT MAXIMUM MATERIAL CONDITION.

| | MILLIMETERS | | | | |
|-----|-------------|-------|--|--|--|
| DIM | MIN | MAX | | | |
| Α | 2.35 | 2.65 | | | |
| A1 | 0.10 | 0.25 | | | |
| В | 0.35 | 0.49 | | | |
| С | 0.23 | 0.32 | | | |
| D | 10.15 | 10.45 | | | |
| Е | 7.40 | 7.60 | | | |
| е | 1.27 | BSC | | | |
| Н | 10.05 | 10.55 | | | |
| h | 0.25 | 0.75 | | | |
| L | 0.50 | 0.90 | | | |
| q | 0 ° | 7 ° | | | |

PACKAGE DIMENSIONS

SOEIAJ-16 CASE 966-01 ISSUE A



NOTES:

- 1. DIMEINU. Y14.5M, 1982. DIMENSIONING AND TOLERANCING PER ANSI
- TH-3-M, 1962.

 CONTROLLING DIMENSION: MILLIMETER.

 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS AND ARE MEASURED AT THE PARTING LINE. MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.15 (0.006) PER SIDE. I. TERMINAL NUMBERS ARE SHOWN FOR
- REFERENCE ONLY. 5. THE LEAD WIDTH DIMENSION (b) DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE LEAD WIDTH
 DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSIONS AND ADJACENT LEAD TO BE 0.46 (0.018).

| | MILLIN | IETERS | INC | HES |
|----------------|--------|--------|-----------|-------|
| DIM | MIN | MAX | MIN | MAX |
| Α | | 2.05 | | 0.081 |
| A ₁ | 0.05 | 0.20 | 0.002 | 0.008 |
| þ | 0.35 | 0.50 | 0.014 | 0.020 |
| O | 0.10 | 0.20 | 0.007 | 0.011 |
| D | 9.90 | 10.50 | 0.390 | 0.413 |
| Е | 5.10 | 5.45 | 0.201 | 0.215 |
| е | 1.27 | BSC | 0.050 BSC | |
| HE | 7.40 | 8.20 | 0.291 | 0.323 |
| Г | 0.50 | 0.85 | 0.020 | 0.033 |
| LE | 1.10 | 1.50 | 0.043 | 0.059 |
| M | 0 ° | 10 ° | 0 ° | 10° |
| ď | 0.70 | 0.90 | 0.028 | 0.035 |
| Z | | 0.78 | | 0.031 |

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